

Application/Control No.	Applicant(s)/Patent under Reexamination
09/311,313	MCBRIDE, JOHN G
Examiner	Art Unit
Leigh Marie Garbowski	2825

	SEARCHED		
Class	Subclass	Date	Examiner
716	1-2,4-6,17- 18	3/18/2005	LMG
703	13-14	3/18/2005	LMG
			±
	-		

INI	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
			-

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
· · · · · · · · · · · · · · · · · · ·	DATE	EXMR
WEST and IEEExplore identif\$ determin\$ analy\$ feedback transistor fet field effect transistor drc rule verif\$ loop pfet nfet	3/18/2005	LMG
consulted Matthew Smith [SPE 2825] regarding 112 rejections	3/17/2005	LMG
		1
·		